

PJQ4416EP

20V N-Channel Enhancement Mode MOSFET

Voltage **20 V** **Current** **30 A**

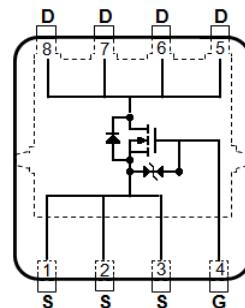
Features

- $R_{DS(ON)}$, $V_{GS} @ 4.5V$, $I_D @ 10A < 11m\Omega$
- $R_{DS(ON)}$, $V_{GS} @ 2.5V$, $I_D @ 9A < 13m\Omega$
- $R_{DS(ON)}$, $V_{GS} @ 1.8V$, $I_D @ 8A < 17m\Omega$
- Advanced Trench Process Technology
- High density cell design for ultralow on-resistance
- Lead free in compliance with EU RoHS 2.0
- Green molding compound as per IEC 61249 standard

Mechanical Data

- Case : DFN3333-8L Package
- Terminals : Solderable per MIL-STD-750, Method 2026
- Approx. Weight : 0.03 grams

DFN3333-8L



Maximum Ratings and Thermal Characteristics ($T_A=25^\circ C$ unless otherwise noted)

PARAMETER		SYMBOL	LIMIT	UNITS
Drain-Source Voltage	V_{DS}		20	V
	V_{GS}		± 10	
Continuous Drain Current(^{Note 4})	$T_C=25^\circ C$	I_D	30	A
	$T_C=100^\circ C$		19	
Pulsed Drain Current(^{Note 1})	$T_C=25^\circ C$	I_{DM}	120	W
Power Dissipation	$T_C=25^\circ C$	P_D	26	
	$T_C=100^\circ C$		10.4	
Continuous Drain Current(^{Note 4})	$T_A=25^\circ C$	I_D	11	A
	$T_A=70^\circ C$		8	
Power Dissipation	$T_A=25^\circ C$	P_D	2	W
	$T_A=70^\circ C$		1.3	
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55~150	$^\circ C$
Typical Thermal Resistance(^{Note 4,5})	Junction to Case	$R_{\theta JC}$	4.8	$^\circ C/W$
	Junction to Ambient	$R_{\theta JA}$	62.5	

- Limited only By Maximum Junction Temperature

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Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNITS
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	20	-	-	V
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	0.3	0.6	1	
Drain-Source On-State Resistance	$R_{\text{DS(on)}}$	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=10\text{A}$	-	9.3	11	$\text{m}\Omega$
		$V_{\text{GS}}=2.5\text{V}, I_{\text{D}}=9\text{A}$	-	11	13	
		$V_{\text{GS}}=1.8\text{V}, I_{\text{D}}=8\text{A}$	-	14.5	17	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 10\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 10	μA
Dynamic ^(Note 6)						
Total Gate Charge	Q_g	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=9\text{A}, V_{\text{GS}}=4.5\text{V}$ ^(Note 2,3)	-	16	-	nC
Gate-Source Charge	Q_{gs}		-	1.3	-	
Gate-Drain Charge	Q_{gd}		-	1.6	-	
Input Capacitance	C_{iss}	$V_{\text{DS}}=10\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	1177	-	pF
Output Capacitance	C_{oss}		-	157	-	
Reverse Transfer Capacitance	C_{rss}		-	134	-	
Turn-On Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}}=10\text{V}, I_{\text{D}}=1\text{A}, V_{\text{GS}}=4.5\text{V}, R_{\text{G}}=25\Omega$ ^(Note 2,3)	-	16	-	ns
Turn-On Rise Time	t_r		-	25	-	
Turn-Off Delay Time	$t_{\text{d(off)}}$		-	124	-	
Turn-Off Fall Time	t_f		-	101	-	
Drain-Source Diode						
Maximum Continuous Drain-Source Diode Forward Current	I_s	---	-	-	30	A
Diode Forward Voltage	V_{SD}	$I_s=1\text{A}, V_{\text{GS}}=0\text{V}$	-	0.73	1	V

NOTES :

1. Pulse width $\leq 300\text{us}$, Duty cycle $\leq 2\%$.
2. Essentially independent of operating temperature typical characteristics.
3. Repetitive rating, pulse width limited by junction temperature $T_{\text{J(MAX)}}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_{\text{J}}=25^\circ\text{C}$.
4. The maximum current rating is package limited.
5. R_{eJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. Mounted on a 1 inch² with 2oz.square pad of copper.
6. Guaranteed by design, not subject to production testing.

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TYPICAL CHARACTERISTIC CURVES

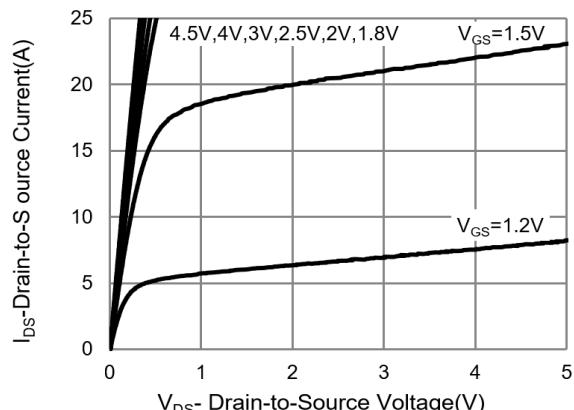


Fig.1 On-Region Characteristics

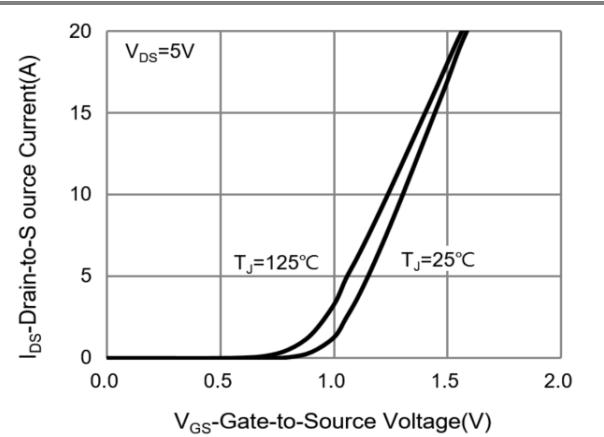


Fig.2 Transfer Characteristics

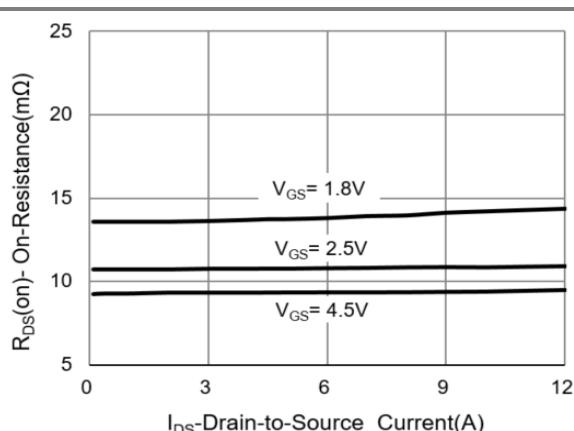


Fig.3 On-Resistance vs. Drain Current

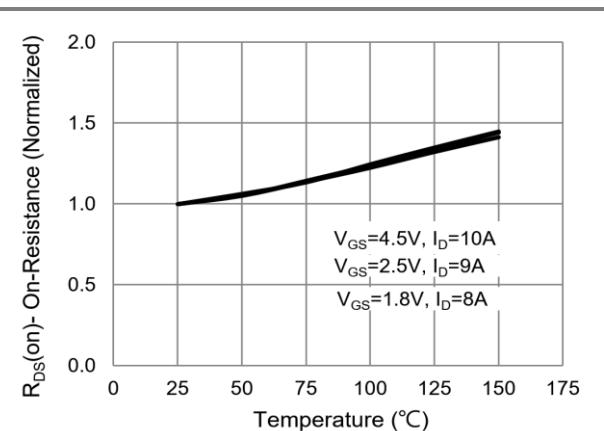


Fig.4 On-Resistance vs. Junction temperature

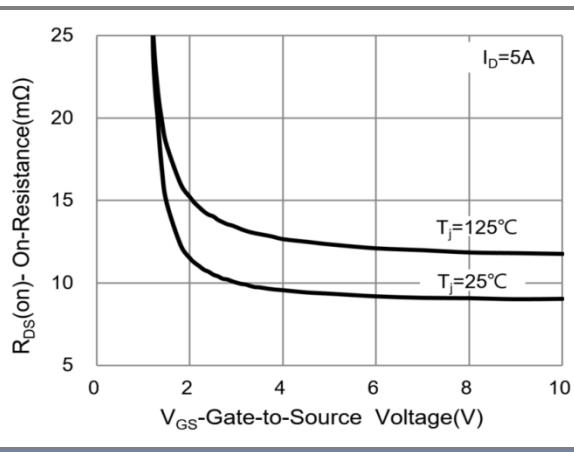


Fig.5 On-Resistance Variation with V_{GS}

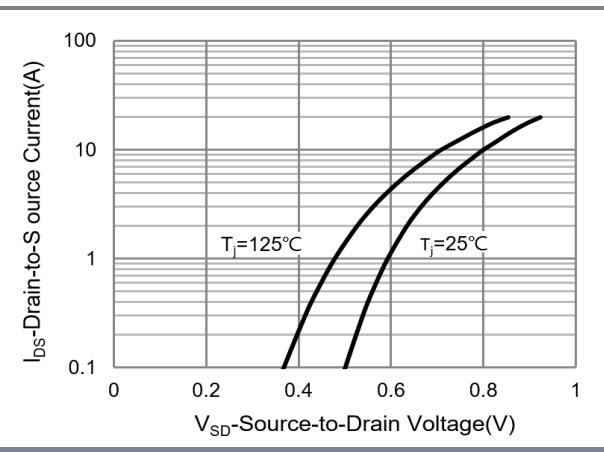


Fig.6 Source-Drain Diode Forward Voltage

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TYPICAL CHARACTERISTIC CURVES

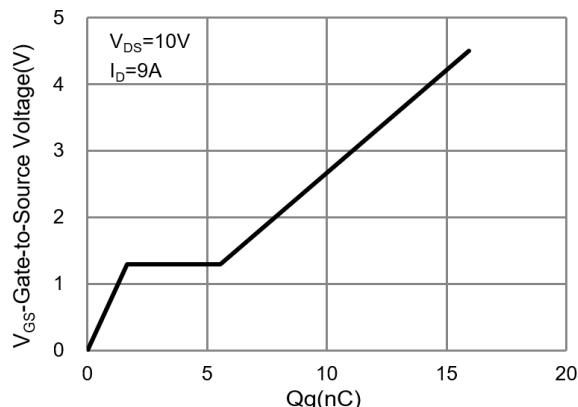


Fig.7 Gate-Charge Characteristics

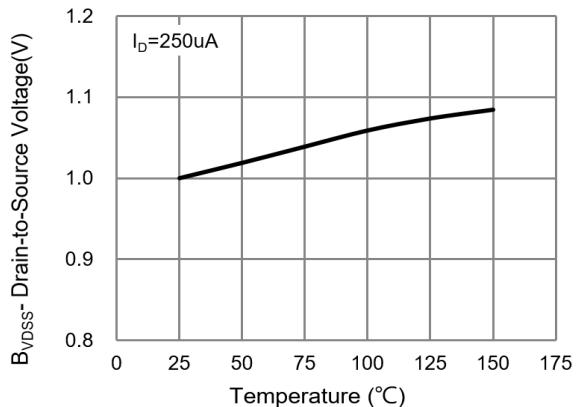


Fig.8 Breakdown Voltage Variation vs. Temperature

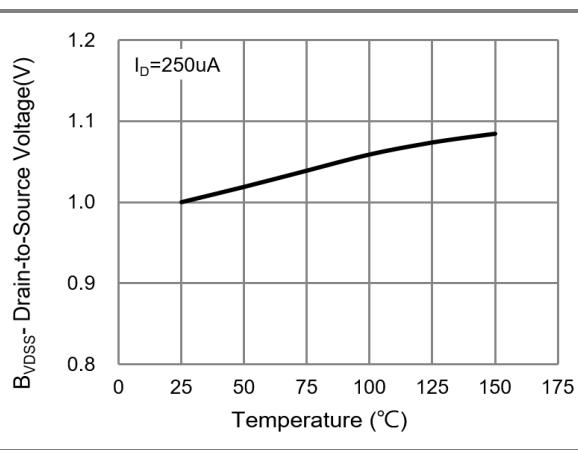


Fig.9 Threshold Voltage Variation with Temperature

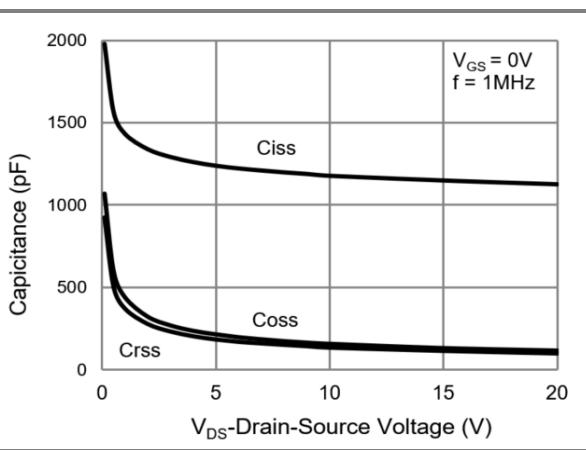


Fig.10 Capacitance vs. Drain-Source Voltage

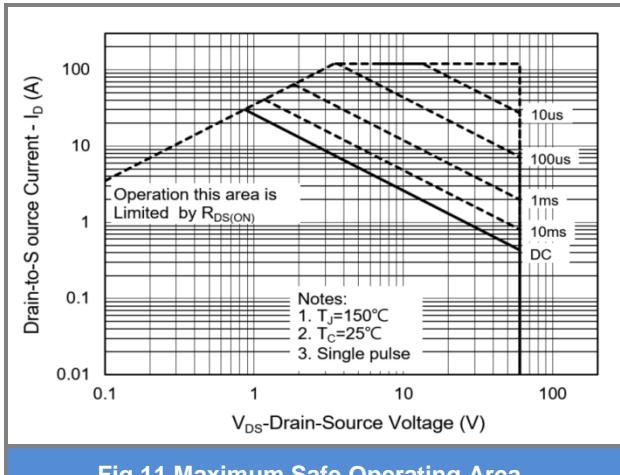


Fig.11 Maximum Safe Operating Area

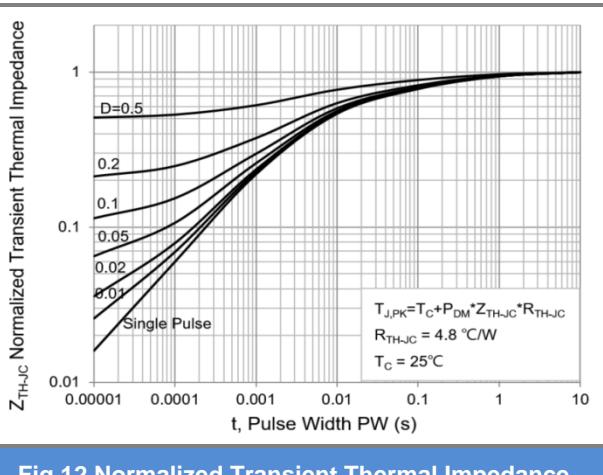


Fig.12 Normalized Transient Thermal Impedance

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Part No. Packing Code Version

Part No. Packing Code	Package Type	Packing Type	Marking	Version
PJQ4416EP_R2_00001	DFN3333-8L	5K pcs / 13" reel	416E	Halogen free RoHS compliant

Packaging Information & Mounting Pad Layout

